

# FCP16N60N / FCPF16N60NT N-Channel SupreMOS<sup>®</sup> MOSFET **600 V, 16 A, 199 m**Ω

## **Features**

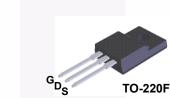
- $R_{DS(on)}$  = 170 m $\Omega$  (Typ.) @  $V_{GS}$  = 10 V,  $I_D$  = 8 A
- Ultra Low Gate Charge (Typ. Q<sub>q</sub> = 40.2 nC)
- Low Effective Output Capacitance (Typ. Coss(eff.) = 176 pF)
- 100% Avalanche Tested
- · RoHS Compliant

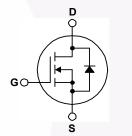
# Application

- LCD/LED/PDP TV
- Lighting
- · Solar Inverter
- · AC-DC Power Supply

# Description

The SupreMOS<sup>®</sup> MOSFET is Fairchild Semiconductor's next generation of high voltage super-junction (SJ) technology employing a deep trench filling process that differentiates it from the conventional SJ MOSFETs. This advanced technology and precise process control provides lowest Rsp on-resistance, superior switching performance and ruggedness. SupreMOS MOSFET is suitable for high frequency switching power converter applications such as PFC, server/telecom power, FPD TV power, ATX power, and industrial power applications.





## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

**TO-220** 

	Parameter			FCPF16N60NT	Unit	
Drain to Source Voltage			6	V		
Gate to Source Voltage			±	:30	V	
Desire Coment	- Continuous (T <sub>C</sub> = 25 <sup>o</sup> C)	- Continuous (T <sub>C</sub> = 25°C)		16.0*	٨	
Drain Current	- Continuous (T <sub>C</sub> = 100 <sup>o</sup> C)		10.1	10.1*	A	
Drain Current	- Pulsed	(Note 1)	48.0	48.0*	Α	
Single Pulsed Avalanche	(Note 2)	3	mJ			
Avalanche Current		(Note 1)	5.3		Α	
Repetitive Avalanche Energy		(Note 1)	1.34		mJ	
MOSFET dv/dt			100		V/ns	
Peak Diode Recovery dv/dt		(Note 3)	20		V/ns	
Devuer Dissingtion	$(T_{C} = 25^{\circ}C)$	$(T_{\rm C} = 25^{\rm o}{\rm C})$		35.7	W	
Power Dissipation	- Derate Above 25°C		1.08	0.29	W/ºC	
Operating and Storage Temperature Range			-55 to	°C		
<ul> <li>Operating and Storage Temperature Range</li> <li>Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds</li> </ul>			300		°C	
	Gate to Source Voltage Drain Current Drain Current Single Pulsed Avalanche Avalanche Current Repetitive Avalanche En MOSFET dv/dt Peak Diode Recovery dv Power Dissipation Operating and Storage T	$\begin{array}{c} \mbox{Drain to Source Voltage} \\ \mbox{Gate to Source Voltage} \\ \mbox{Gate to Source Voltage} \\ \mbox{Drain Current} & - Continuous (T_C = 25^{\circ}C) \\ - Continuous (T_C = 100^{\circ}C) \\ \mbox{Drain Current} & - Pulsed \\ \mbox{Single Pulsed Avalanche Energy} \\ \mbox{Avalanche Current} \\ \mbox{Repetitive Avalanche Energy} \\ \mbox{MOSFET dv/dt} \\ \mbox{Peak Diode Recovery dv/dt} \\ \mbox{Power Dissipation} & \frac{(T_C = 25^{\circ}C) \\ - Derate Above 25^{\circ}C \\ \mbox{Operating and Storage Temperature Range} \\ \end{array}$	$\begin{array}{c} \mbox{Drain to Source Voltage} \\ \mbox{Gate to Source Voltage} \\ \mbox{Gate to Source Voltage} \\ \mbox{Drain Current} & - \mbox{Continuous} (T_C = 25^{\circ}C) \\ \mbox{- Continuous} (T_C = 100^{\circ}C) \\ \mbox{- Note 1} \\ \mbox{Note 2} \\ \mbox{Avalanche Current} & (Note 1) \\ \mbox{Repetitive Avalanche Energy} & (Note 1) \\ \mbox{Repetitive Avalanche Energy} & (Note 1) \\ \mbox{Repetitive Avalanche Energy} & (Note 1) \\ \mbox{MOSFET dv/dt} \\ \mbox{Peak Diode Recovery dv/dt} & (Note 3) \\ \mbox{Power Dissipation} & \frac{(T_C = 25^{\circ}C) \\ \mbox{- Derate Above 25^{\circ}C} \\ \mbox{Operating and Storage Temperature Range} \\ \end{array}$	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	

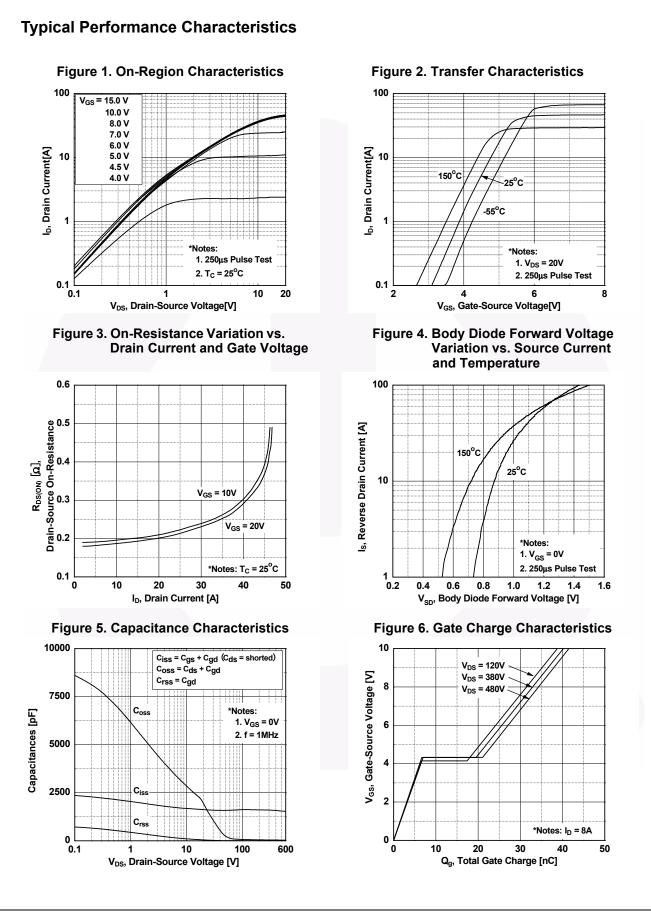
Drain current limited by maximum junction temperature.

# **Thermal Characteristics**

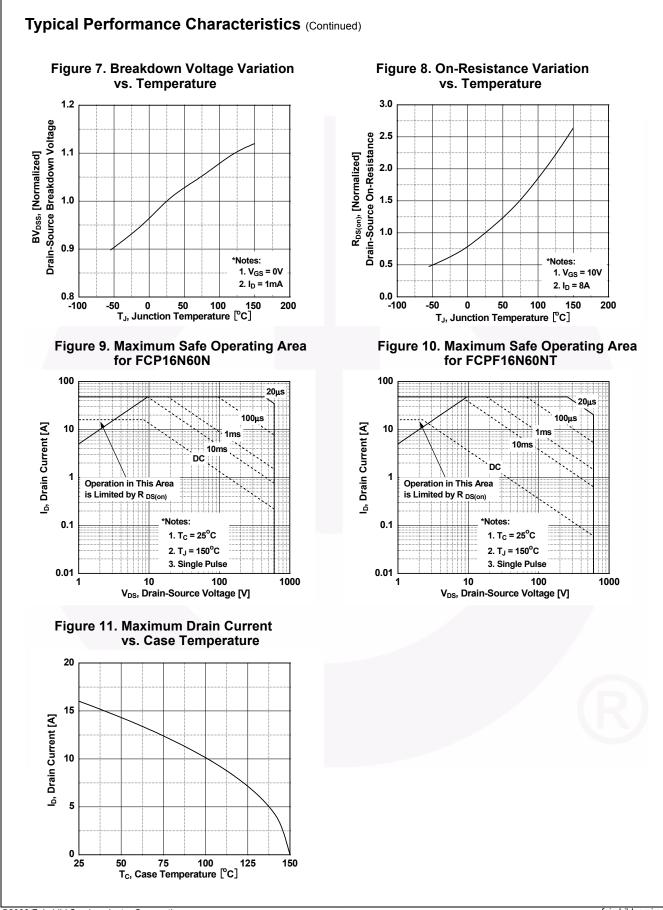
Symbol	Parameter	FCP16N60N	FCPF16N60NT	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	0.93	3.5	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	62.5	0/11

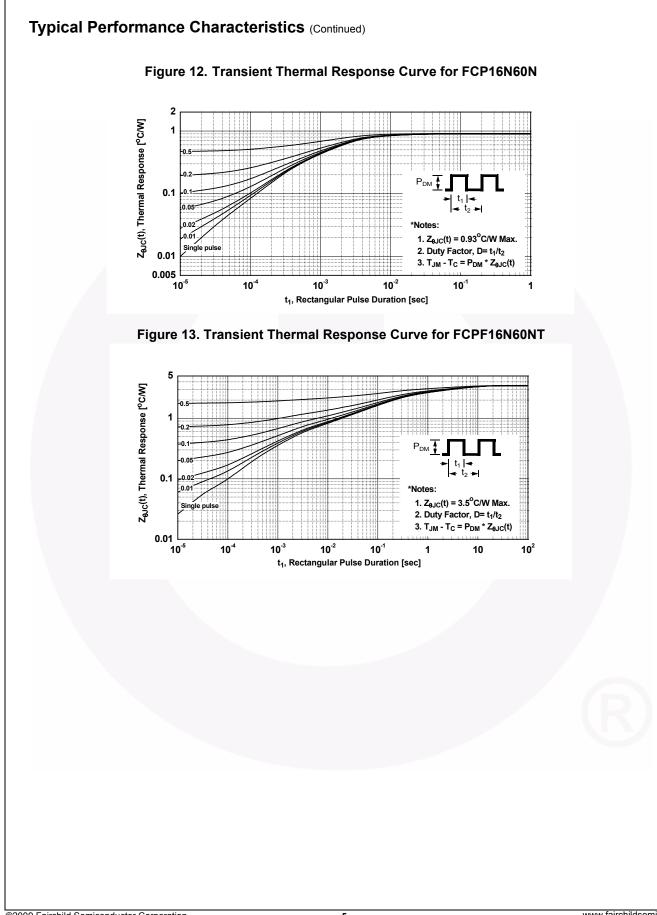
November 2013

Part Nur	nber	Top Mark	Pack	age	Packing Method	Reel Size	Та	pe Width	Qua	ntity	
FCP16N	160N	FCP16N60N	TO-2	220	Tube	N/A		N/A	50	50 units	
FCPF16N	160NT	FCPF16N60NT	TO-2	20F	Tube	N/A		N/A	50 units		
Electrica	l Chara	acteristics T <sub>C</sub> = 2	5ºC unle	ss othe	erwise noted.						
Symbol		Parameter	-		Test Condition	ns	Min.	Тур.	Max.	Uni	
Off Charac	teristics	6									
BV <sub>DSS</sub>	Drain to	Source Breakdown Vol	tage	In	= 1 mA, V <sub>GS</sub> = 0V, T <sub>C</sub>	= 25°C	600	-	-	V	
ΔBV <sub>DSS</sub> / ΔT <sub>.l</sub>		wn Voltage Temperatur	-	$I_D = 1$ mA, Referenced to 25°C			-	0.73	-	V/ºC	
				V	<sub>DS</sub> = 480 V, V <sub>GS</sub> = 0 V		-	-	10		
DSS	SS Zero Gate Voltage Drain Current		it	$V_{DS} = 480 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$			-	-	100	μA	
I <sub>GSS</sub>	Gate to I	Body Leakage Current			$_{\rm SS} = \pm 30 \text{ V}, \text{ V}_{\rm DS} = 0 \text{ V}$		-	-	±100	nA	
On Charac	teristics	5									
V <sub>GS(th)</sub>		reshold Voltage	-	V	<sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA		2.0	-	4.0	V	
R <sub>DS(on)</sub>		ain to Source On Resis	tance		$_{3S} = 10 \text{ V}, \text{ I}_{D} = 8 \text{ A}$		-	0.170	0.199	Ω	
9FS		Transconductance		$V_{DS} = 40 \text{ V}, \text{ I}_{D} = 8 \text{ A}$			-	13	-	S	
										1	
C <sub>iss</sub>	Input Capacitance					<u> </u>	1630	2170	pF		
		Capacitance	-	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, f = 1 MHz		_		70	95	pF	
C <sub>oss</sub>	-	Transfer Capacitance	_				5	10	pF		
C <sub>rss</sub>		out Capacitance		V <sub>DS</sub> = 380 V, V <sub>GS</sub> = 0 V, f = 1 MHz				40	60	pF	
C <sub>oss</sub>	-	Effective Output Capacitance		$V_{DS} = 0.00 \text{ V}, V_{GS} = 0.00 \text{ V}, 1 = 1.0012$ $V_{DS} = 0.00 \text{ to } 480 \text{ V}, V_{GS} = 0.00 \text{ V}$			-	176		pF	
C <sub>oss(eff.)</sub> Q <sub>g(tot)</sub>		Total Gate Charge at 10V				-	40.2	52.3	nC		
$Q_{gs}$		Source Gate Charge			$V_{DS} = 380 \text{ V}, \text{ I}_{D} = 8 \text{ A},$		-	6.7	-	nC	
∝ <sub>gs</sub> Q <sub>gd</sub>		Drain "Miller" Charge		V <sub>GS</sub> = 10 V (Note 4)		-	12.9	-	nC		
esr	Equivalent Series Resistance (G-S)		3-S)	f = 1 MHz				2.9		Ω	
Switching	· ·	,	/				_				
•								15.8	41.6	ns	
t <sub>d(on)</sub> t <sub>r</sub>	Turn-On Delay Time Turn-On Rise Time			Vr	V <sub>DD</sub> = 380 V, I <sub>D</sub> = 8 A,			15.5	41.0	ns	
r t <sub>d(off)</sub>		Delay Time			$_{\rm GS}$ = 10 V, R <sub>G</sub> = 4.7 $\Omega$	_	-	60.3	130.6	ns	
t <sub>f</sub>		Fall Time			(Note 4)		-	20.2	50.4	ns	
						(		_0			
		e Characteristics		odo Er				_	16	A	
l <sub>S</sub> Isu	Maximum Continuous Drain to Source							48	A		
I <sub>SM</sub> V <sub>SD</sub>	Maximum Pulsed Drain to Source Diod Drain to Source Diode Forward Voltage			$V_{GS} = 0 V, I_{SD} = 8 A$				-	1.2	V	
t <sub>rr</sub>		Recovery Time	voltage				-	319	-	ns	
Q <sub>rr</sub>		Recovery Charge			V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 8 A, dI <sub>F</sub> /dt = 100 A/μs		-	4.4	_	μΟ	
		ricectery enalge			•					μο	
. I <sub>AS</sub> = 5.3 A, R <sub>G</sub>	= 25 Ω, starting ≤ 200 A/μs, V <sub>I</sub>	imited by maximum junction ter g T <sub>J</sub> = 25°C. <sub>DD</sub> = 380 V, starting T <sub>J</sub> = 25°C erating temperature typical char									

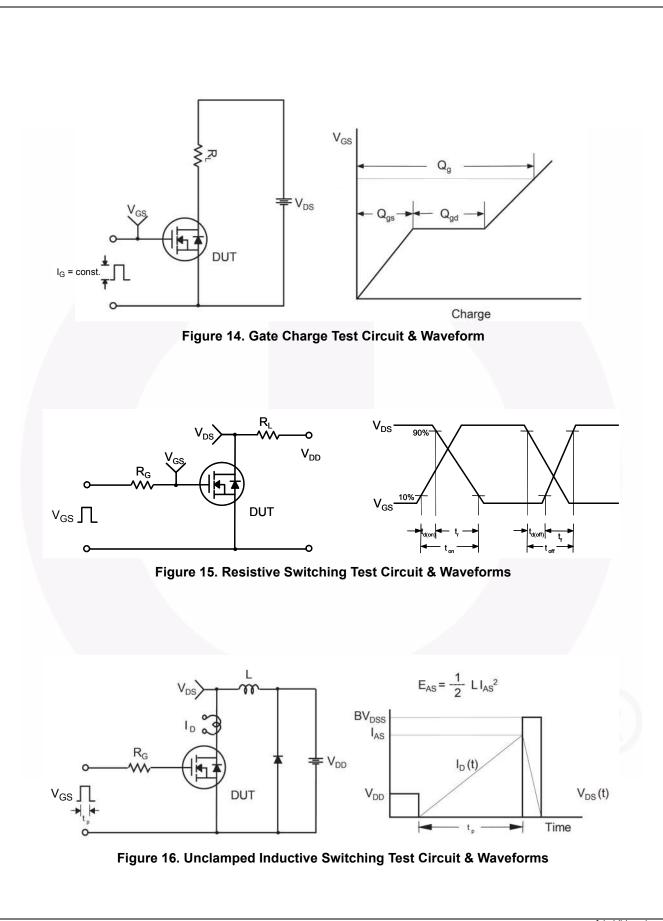


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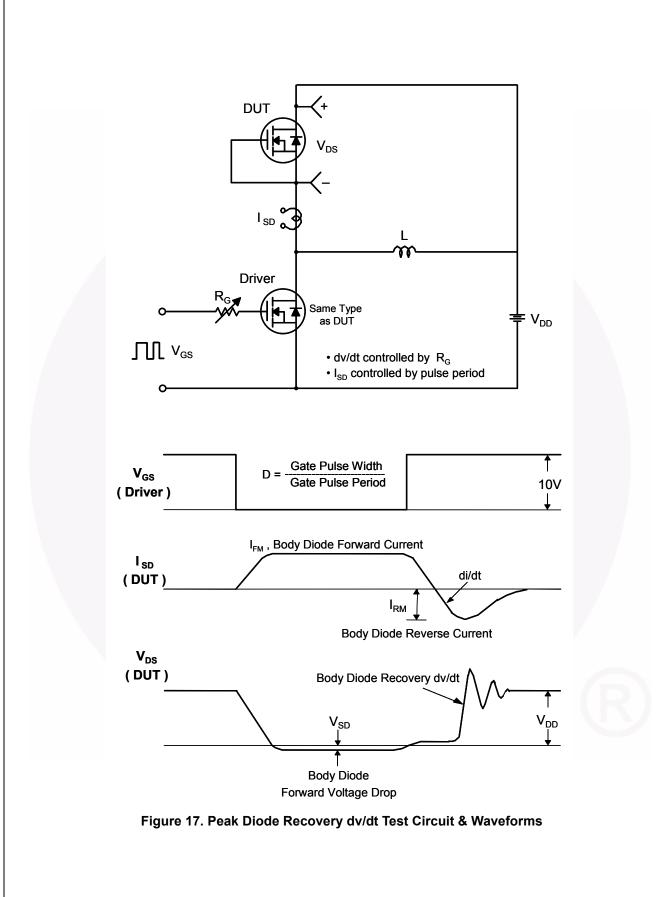




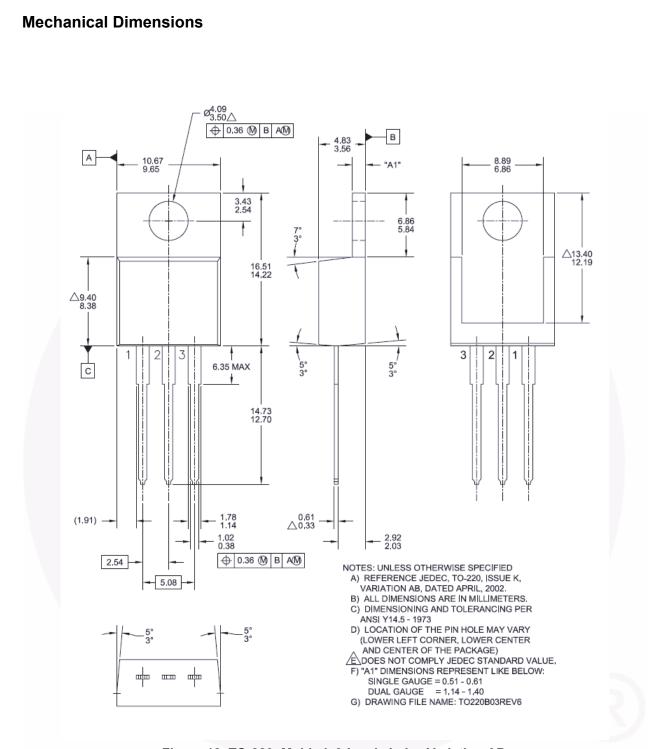
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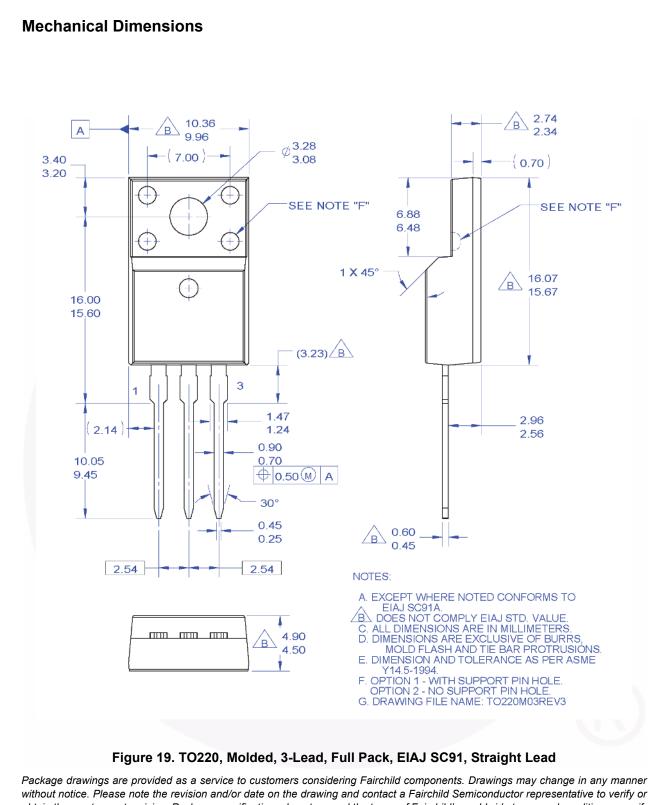


## Figure 18. TO-220, Molded, 3-Lead, Jedec Variation AB

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